

Notice of References Cited	Application/Control No. 10/659,699	Applicant(s)/Patent Under Reexamination KO ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2003/0128317	07-2003	Ohmuro et al.	349/113
	C	US-			
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